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Kind regards,

Team Nexperia



Unidirectional quadruple ESD protection diode arrays Rev. 01 — 17 January 2008

Product data sheet

Product profile 1.

1.1 General description

Unidirectional quadruple ElectroStatic Discharge (ESD) protection diode arrays in a small SOT886 Surface-Mounted Device (SMD) plastic package designed to protect up to four signal lines from the damage caused by ESD and other transients.

1.2 Features

- ESD protection of up to four lines
- Max. peak pulse power: P_{PP} = 110 W
- Low clamping voltage: V_{CL} = 11 V
- Ultra low leakage current: I_{RM} = 4 nA

1.3 Applications

- Computers and peripherals
- Audio and video equipment

1.4 Quick reference data

Cellular handsets and accessories

IEC 61000-4-2; level 4 (ESD) IEC 61000-4-5 (surge); I_{PP} = 10 A

ESD protection up to 30 kV

- AEC-Q101 qualified
- Communication systems
- Portable electronics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode)					
V _{RWM}	reverse standoff voltage					
	PESD3V3S4UF		-	-	3.3	V
	PESD5V0S4UF		-	-	5.0	V
C _d	diode capacitance	$f = 1 \text{ MHz}; V_R = 0 \text{ V}$				
	PESD3V3S4UF		-	110	300	pF
	PESD5V0S4UF		-	85	220	pF



Unidirectional quadruple ESD protection diode arrays

2. Pinning information

Table 2.	Pinning		
Pin	Description	Simplified outline	Symbol
1	cathode (diode 1)		
2	common anode		1 - [□ + □] - 6
3	cathode (diode 2)		2 5
4	cathode (diode 3)		3
5	common anode		006aaa156
6	cathode (diode 4)	6 5 4 bottom view	

3. Ordering information

Table 3. Order	ing information	on	
Type number	Package		
	Name	Description	Version
PESD3V3S4UF	XSON6	plastic extremely thin small outline package;	SOT886
PESD5V0S4UF		no leads; 6 terminals; body $1 \times 1.45 \times 0.5$ mm	

4. Marking

Marking code ^[1]
A3
A4
A

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

* = W: made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per diode					
P _{PP}	peak pulse power	$t_p = 8/20 \ \mu s$	[1][2] _	110	W
I _{PP}	peak pulse current	t _p = 8/20 μs	<u>[1][2]</u> _	10	А

PESD3V3S4UF_PESD5V0S4UF_1

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Limiting values ... continued Table 5.

In accordance with the Absolute Maximum Rating System (IEC 60134).

Per device T_j junction temperature-150°C T_{amb} ambient temperature-55+150°C T_{sto} storage temperature-65+150°C	Symbol	Parameter	Conditions	Min	Max	Unit
T_{amb} ambient temperature -55 +150 °C	Per device					
	T _j	junction temperature		-	150	°C
T _{sto} storage temperature –65 +150 °C	T _{amb}	ambient temperature		-55	+150	°C
	T _{stg}	storage temperature		-65	+150	°C

[1] Non-repetitive current pulse 8/20 μs exponential decay waveform according to IEC 61000-4-5.

[2] Measured from pin 1, 3, 4 or 6 to pin 2 or 5.

Table 6. **ESD** maximum ratings

 $T_{amb} = 25 \circ C$ unless otherwise specified.

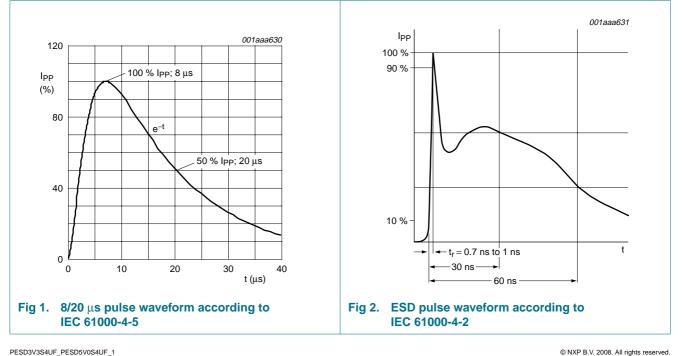
Symbol	Parameter	Conditions		Min	Max	Unit
Per diode	•					
V_{ESD}	electrostatic discharge voltage	IEC 61000-4-2 (contact discharge)	[1][2]	-	30	kV
		MIL-STD-883 (human body model)		-	10	kV

[1] Device stressed with ten non-repetitive ESD pulses.

[2] Measured from pin 1, 3, 4 or 6 to pin 2 or 5.

Table 7. **ESD** standards compliance

Standard	Conditions
Per diode	
IEC 61000-4-2; level 4 (ESD)	> 15 kV (air); > 8 kV (contact)
MIL-STD-883; class 3 (human body model)	> 4 kV



Product data sheet

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Unidirectional quadruple ESD protection diode arrays

6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diod	e					
V _{RWM}	reverse standoff voltage					
	PESD3V3S4UF		-	-	3.3	V
	PESD5V0S4UF		-	-	5.0	V
I _R	reverse current					
	PESD3V3S4UF	V _R = 3.0 V	-	100	1000	nA
	PESD5V0S4UF	V _R = 4.3 V	-	4	100	nA
V _{BR}	breakdown voltage	I _R = 1 mA				
	PESD3V3S4UF		5.32	5.6	5.88	V
	PESD5V0S4UF		6.46	6.8	7.14	V
C _d	diode capacitance	$f = 1 MHz; V_R = 0 V$				
	PESD3V3S4UF		-	110	300	pF
	PESD5V0S4UF		-	85	220	pF
V _{CL}	clamping voltage		[1][2]			
	PESD3V3S4UF	I _{PP} = 1 A	-	-	8	V
		I _{PP} = 10 A	-	-	11	V
	PESD5V0S4UF	I _{PP} = 1 A	-	-	8	V
		I _{PP} = 10 A	-	-	12	V
r _{dif}	differential resistance	I _R = 1 mA				
	PESD3V3S4UF		-	-	400	Ω
	PESD5V0S4UF		-	-	200	Ω

[1] Non-repetitive current pulse 8/20 µs exponential decay waveform according to IEC 61000-4-5.

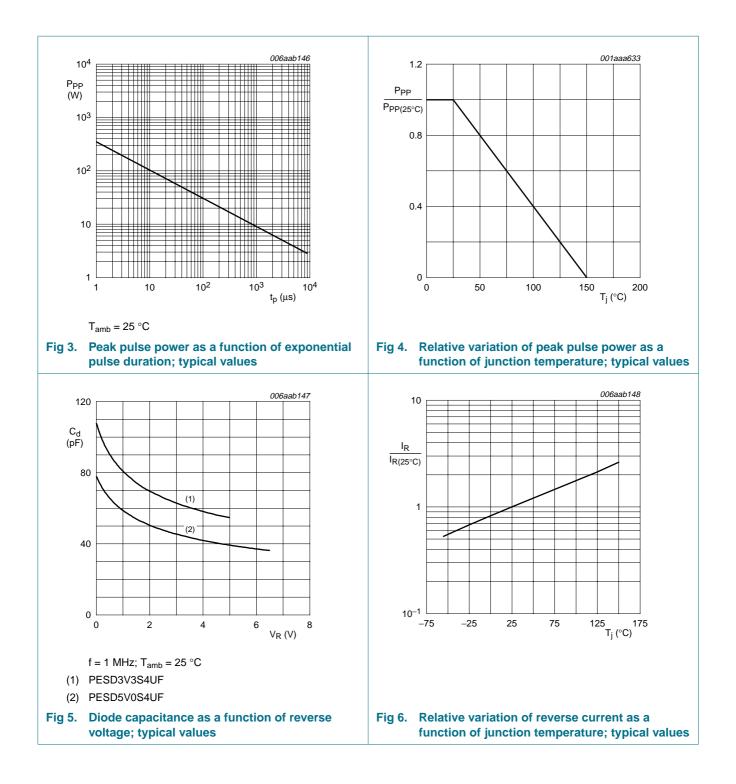
[2] Measured from pin 1, 3, 4 or 6 to pin 2 or 5.

PESD3V3S4UF_PESD5V0S4UF_1

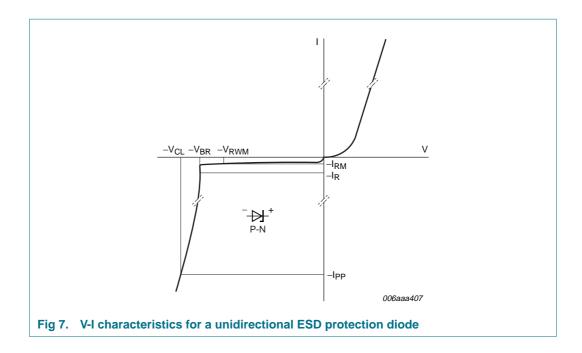
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PESD3V3S4UF; PESD5V0S4UF

Unidirectional quadruple ESD protection diode arrays

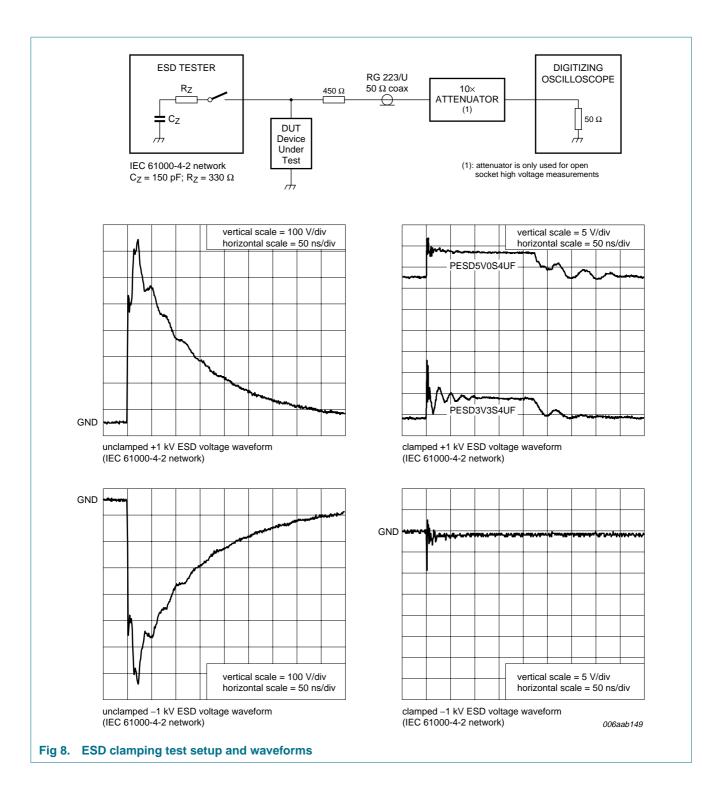


Unidirectional quadruple ESD protection diode arrays



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Unidirectional quadruple ESD protection diode arrays

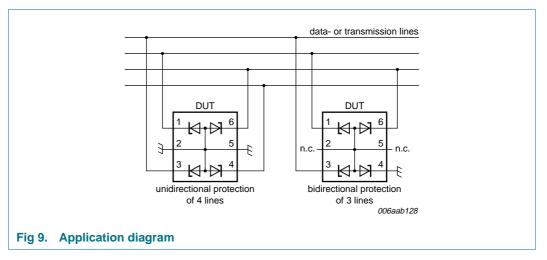


PESD3V3S4UF_PESD5V0S4UF_1
Product data sheet

Unidirectional quadruple ESD protection diode arrays

7. Application information

The PESDxS4UF is designed for the protection of up to four unidirectional data or signal lines from the damage caused by ESD and surge pulses. The PESDxS4UF may be used on lines where the signal polarities are either positive or negative with respect to ground. The PESDxS4UF provides a surge capability of 110 W per line for an 8/20 μ s waveform each.



Circuit board layout and protection device placement

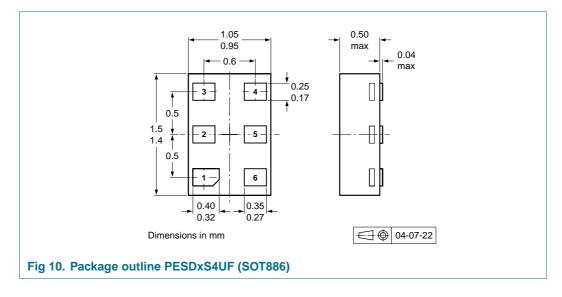
Circuit board layout is critical for the suppression of ESD, Electrical Fast Transient (EFT) and surge transients. The following guidelines are recommended:

- 1. Place the PESDxS4UF as close to the input terminal or connector as possible.
- 2. The path length between the device and the protected line should be minimized.
- 3. Keep parallel signal paths to a minimum.
- 4. Avoid running protected conductors in parallel with unprotected conductors.
- 5. Minimize all Printed-Circuit Board (PCB) conductive loops including power and ground loops.
- 6. Minimize the length of the transient return path to ground.
- 7. Avoid using shared transient return paths to a common ground point.
- 8. Ground planes should be used whenever possible. For multilayer PCBs, use ground vias.

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Unidirectional quadruple ESD protection diode arrays

8. Package outline



9. Packing information

Table 9. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description		Packing quantity 5000
PESD3V3S4UF	SOT886	4 mm pitch, 8 mm tape and reel; T1		-115
		4 mm pitch, 8 mm tape and reel; T4		-132
PESD5V0S4UF	SOT886	4 mm pitch, 8 mm tape and reel; T1		-115
		4 mm pitch, 8 mm tape and reel; T4	[3]	-132

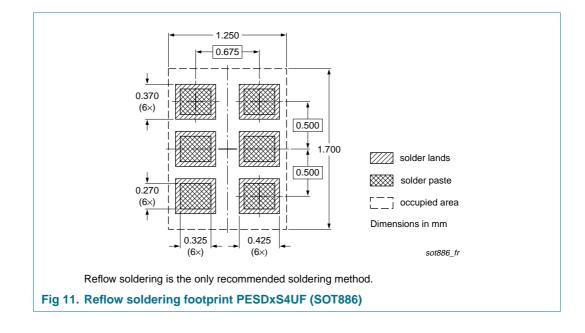
[1] For further information and the availability of packing methods, see Section 13.

[2] T1: normal taping

[3] T4: 90° rotated reverse taping

Unidirectional quadruple ESD protection diode arrays

10. Soldering



PESD3V3S4UF_PESD5V0S4UF_1

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11. Revision history

Table 10. Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes
PESD3V3S4UF_PESD5V0S4UF_1	20080117	Product data sheet	-	-

Unidirectional quadruple ESD protection diode arrays

12. Legal information

12.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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PESD3V3S4UF_PESD5V0S4UF_1

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